

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road, San Jose, CA - 95138

PRODUCT/PROCESS CHANGE NOTICE (PCN)

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PCN #: I-08	09-01	DATE September 22	2, 2008	MEANS OF DISTINGUISHING CHANGED DEVICES:			
Product Affected: 89HPES24T6G2, 89HPES24T3G2.,				■ Product Mark Change in Ordering Part Number			
89HPES16T4AC	G2, 89HPES6T6G2, 8	9HPES4T4G2		☐ Back Mark	Ü		
				☐ Date Code			
Date Effective:	09/22/2008			☐ Other			
Contact:	PS Tow						
Title:	Quality Assurance Di	irector		Attachment::	Yes	☐ No	
Phone #:	(408) 284-8206						
Fax #:	(408) 284-8362			Samples:	N/A		
E-mail:	PS.Tow@idt.com						
DESCRIPTION	N AND PURPOSE O	F CHANGE:					
☐ Die Technology This notification is to advise our			r customers that ID	Γ has qualified a	new die revision to		
☐ Wafer Fabrication Process address device			vice errata. The details are as follow:				
☐ Assembly Process Device die revision from Ma			m Mark	Revision "ZB" to N	Mark Revision "Z	ZC" for the products	
☐ Equipment affected (listed above).					_		
☐ Material							
☐ Testing		There will be a change	in order	ing part number. Ple	ease see attachme	ent for details.	
☐ Manufacturii	ng Site						
Data Sheet							
Other							
RELIABILITY	Y/QUALIFICATION	SUMMARY See attac	hed data	There is no change	to the die techno	ology/process.	
	ACKNOWLEDGME						
IDT records indicate that you require written notification of this change. Please use the acknowledgement below or E-Mail							
to grant approval or request additional information. If IDT does not receive acknowledgement within 30 days of this notice							
	ned that this change is						
IDT reserves the right to ship either version manufactured after the process change effective date until the inventory							
on the earlier vo	ersion has been deplet	ted.					
			$\overline{}$				
Customer:			ш	Approval for sh	ipments prior	r to effective date.	
Name/Date:			E-Ma	il Address:			
Title:			Phone	e# /Fax# :			
CUSTOMER COMMENTS:							
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PRODUCT/PROCESS CHANGE NOTICE (PCN)

ATTACHMENT - PCN #: I- 0809-01

PCN Type: Die revision

Data Sheet Change Yes

Detail of Change This notification is to advise our customers that IDT has qualified a new die revision to address the

device errata. The details are as follow:

Device die revision from Mark Revision "ZB" to Mark Revision "ZC" for devices 89HPES24T6G2,

89HPES24T3G2., 89HPES16T4AG2, 89HPES6T6G2, 89HPES4T4G2

There will be a change in ordering part number. Please see Table 1 for details.

The new die revision will address the known errata items as follow:

For Mark Revision "ZB" Errata

- 1. Eliminate "Less than 16 TS2 sent in response to one received TS2".
- 2. Eliminate "With both Rx and Tx L0s enabled, link may enter Recovery in some situations".

Table 1

ZB to ZC Transition Parts					
Old Part #	New Part #				
89HPES24T6G2ZBAL	89HPES24T6G2ZCAL				
89HPES24T6G2ZBALG	89HPES24T6G2ZCALG				
89HPES24T3G2ZBAL	89HPES24T3G2ZCAL				
89HPES24T3G2ZBALG	89HPES24T3G2ZCALG				
89HPES24T3G2ZBBL	89HPES24T3G2ZCBL				
89HPES24T3G2ZBBLG	89HPES24T3G2ZCBLG				
89HPES24T3G2ZBBR	89HPES24T3G2ZCBR				
89HPES16T4AG2ZBAL	89HPES16T4AG2ZCAL				
89HPES16T4AG2ZBALG	89HPES16T4AG2ZCALG				
89HPES6T6G2ZBAL	89HPES6T6G2ZCAL				
89HPES6T6G2ZBALG	89HPES6T6G2ZCALG				
89HPES4T4G2ZBAL	89HPES4T4G2ZCAL				
89HPES4T4G2ZBALG	89HPES4T4G2ZCALG				

Note: For T&R, "8" suffix is added to the part#

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ATTACHMENT - PCN #: I-0809-01

Qualification Data

Test Vehicle: 89HPES24T6G2

Qualification Test Plan and Results:

Test Description	Sample Size/ # Of Fails	Test Results (SS/ # Of Fails
Dynamic High Temp Operating Life Test	77/0	77/0
* Temperature Cycling (-65 °C to 150 °C, 500 cycle)	45/0	45/0
* Highly Accelerated Stress Test (HAST) (130 °C,85% RH, 100 Hrs)	45/0	45/0
ESD HBM	3/0	3/0
ESD CDM	3/0	3/0

Notes: * Test requires Moisture Pre-Conditioning sequence.